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DUPLICATE

<small>SEARCHED (initials) (modified)</small> <small>U. S. DEPARTMENT OF COMMERCE</small> <small>PATENT AND TRADEMARK OFFICE</small> <small>MAP 22 LIST OF REFERENCES CITED BY APPLICANT(S)</small> <small>(use several sheets if necessary)</small>		<small>ATTY DOCKET NO.</small> 03500.013949.1.		<small>APPLICATION NO.</small> 10/052,338		
		<small>APPLICANT</small> YOSHIYUKI IMANAKA ET AL.				
		<small>FILING DATE</small> January 23, 2002		<small>GROUP</small> 2853		
U. S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
20	6,224,195 B1	05/01/01	Maru et al.	347	60	
FOREIGN PATENT DOCUMENTS						
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	<i>ALAN DILL</i>		DATE CONSIDERED		<i>10/21/01</i>	

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